MBN1600F17F

Preliminary Specification

Silicon N-channel IGBT 1700V F version

FEATURES

- Soft switching behavior, low switching loss & low conduction loss :
  Soft low-injection punch-through with trench gate IGBT
- Low driving power due to low input capacitance advanced trench MOS gate.
- Ultra soft fast recovery diode.
- High current rate package.
- Low $R_{th(j-c)}$ & low stray inductance.
- RoHS
- High thermal fatigue durability

ABSOLUTE MAXIMUM RATINGS (T_C=25°C)

Item		Symbol	Unit	MBN1600F17F
Collector Emitter Voltage		V_{CES}	V	1,700
Gate Emitter Voltage		V_{GES}	V	±20
Collector Current	DC	I_C	A	1,600
	1ms	I_{CRM}		3,200
Forward Current	DC	I_F	A	1,600
	1ms	I_{FRM}		3,200
Junction Temperature		$T_{vj\ op}$	°C	-50 ~ +150
Storage Temperature		T_{stg}	°C	-50 ~ +150
Isolation Voltage		V_{ISO}	V_{RMS}	4,000(AC 1 minute)
Screw Torque	Terminals (M4/M8)	-	N·m	2/15 (1)
	Mounting (M6)	-		6 (2)

Notes: (1) Recommended Value 1.8±0.2/ 15^{+0}_{-3}N·m (2) Recommended Value 5.5±0.5N·m

ELECTRICAL CHARACTERISTICS

Item	Symbol	Unit	Min.	Typ.	Max.	Test Conditions
Collector Emitter Cut-Off Current	I_{CES}	mA	-	-	5	V_{CE}=1,700V, V_{GE}=0V, T_{vj}=25°C
			-	20	70	V_{CE}=1,700V, V_{GE}=0V, T_{vj}=150°C
Gate Emitter Leakage Current	I_{GES}	nA	-500	-	+500	V_{GE}=±20V, V_{CE}=0V, T_{vj}=25°C
Collector Emitter Saturation Voltage	$V_{CE(sat)}$	V	-	2.0	-	I_C=1,600A, V_{GE}=15V, T_{vj}=25°C
			-	2.3	-	I_C=1,600A, V_{GE}=15V, T_{vj}=125°C
			-	2.4	TBD	I_C=1,600A, V_{GE}=15V, T_{vj}=150°C
Gate Emitter Threshold Voltage	$V_{GE(th)}$	V	4.1	5.5	7.1	V_{CE}=10V, I_C=160mA, T_{vj}=25°C
Input Capacitance	C_{ies}	nF	-	87	-	V_{CE}=10V, V_{GE}=0V, f=100kHz, T_{vj}=25°C
Internal Gate Resistance	$R_{G(int)}$	Ω	-	2.25	-	V_{CE}=10V, V_{GE}=0V, f=100kHz, T_{vj}=25°C
Turn On Delay Time	$t_{d(on)}$	μs	-	0.7	TBD	V_{CC}=900V, I_C=1,600A
Rise Time	t_r		-	0.2	TBD	L_S=65nH (3)
Turn Off Delay Time	$t_{d(off)}$		-	1.5	TBD	R_G(on/off)=4.7/4.7Ω (3)
Fall Time	t_f		-	1.5	TBD	V_{GE}=±15V, T_{vj}=150°C
Peak Forward Voltage Drop	V_F	V	-	2.0	-	I_F=1,600A, V_{GE}=0V, T_{vj}=25°C
			-	2.2	-	I_F=1,600A, V_{GE}=0V, T_{vj}=125°C
			-	2.25	TBD	I_F=1,600A, V_{GE}=0V, T_{vj}=150°C
Reverse Recovery Time	t_{rr}	μs	-	0.75	TBD	V_{CC}=900V, I_C=1,600A
Turn On Loss	E_{on}	J/P	-	0.47	-	L_S=65nH (3)
Turn Off Loss	E_{off}	J/P	-	1.25	-	R_G(on/off)=4.7/4.7Ω (3)
Reverse Recovery Loss	E_{rr}	J/P	-	0.55	-	V_{GE}=±15V, T_{vj}=150°C
Stray inductance module	L_{SCE}	nH	-	10	-	Collector Main to Emitter Main
Thermal Impedance IGBT	$R_{th(j-c)}$	K/W	-	-	0.0165	Junction to case
Thermal Impedance FWD	$R_{th(j-c)}$	K/W	-	-	0.0255	Junction to case
Contact Thermal Impedance	$R_{th(c-f)}$	K/W	-	0.008	-	Case to fin

Notes:(3) Ls and R_G are the test condition's values for evaluation of the switching times, not recommended value. Please, determine the suitable R_G value after the measurement of switching waveforms (overshoot voltage, etc.) with appliance mounted.

* Please contact our representatives at order.
* For improvement, specifications are subject to change without notice.
* For actual application, please confirm this spec sheet is the newest revision.
* ELECTRICAL CHARACTERISTIC items shown in above table are according to IEC 60747–2 and IEC 60747–9.

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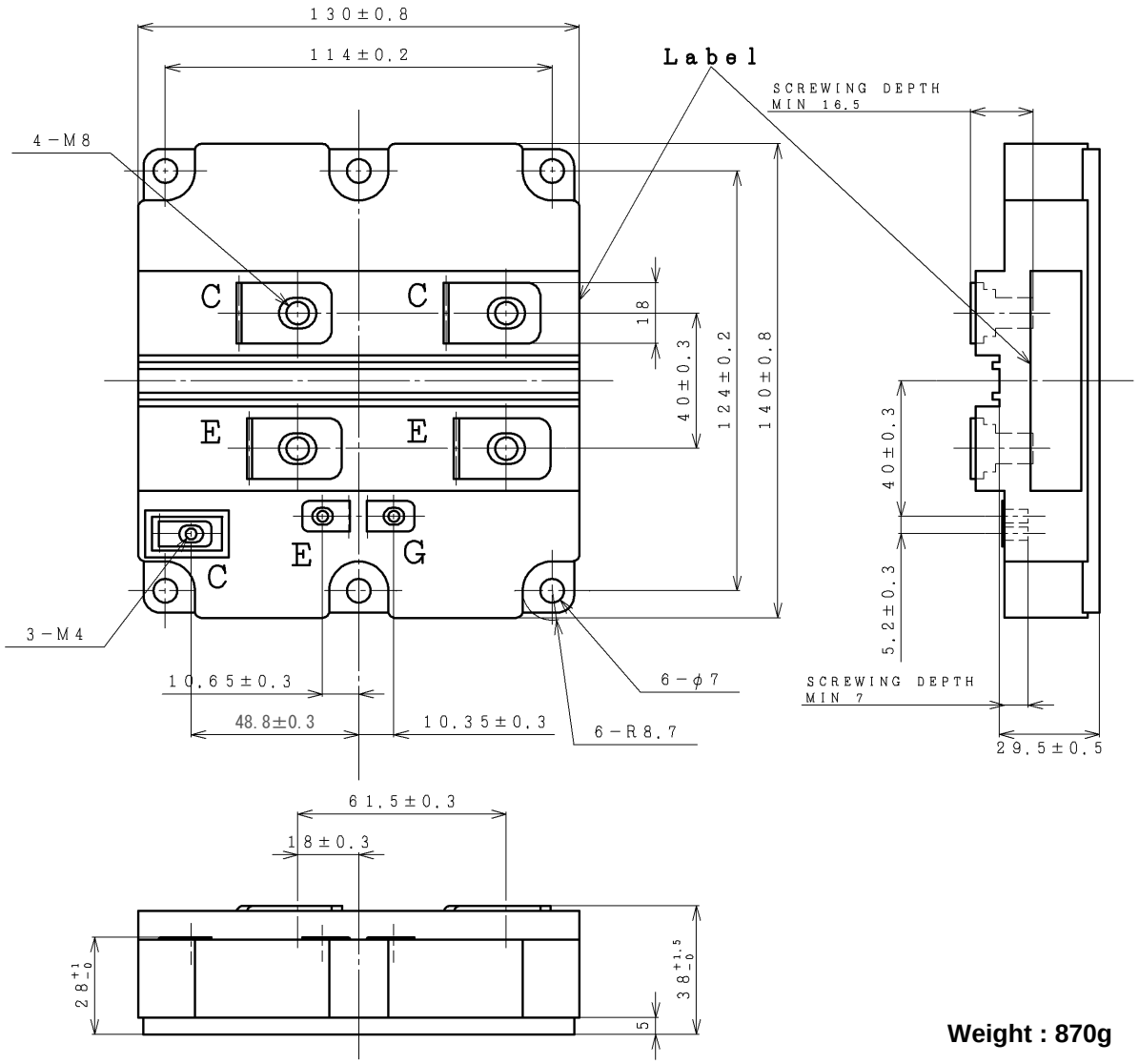
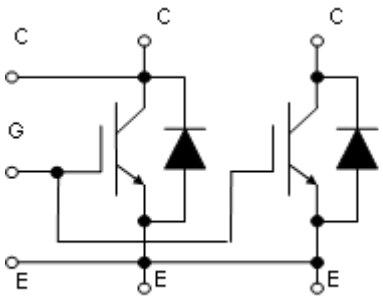
OUTLINE DRAWING

Unit in mm



Weight : 870g

CIRCUIT DIAGRAM



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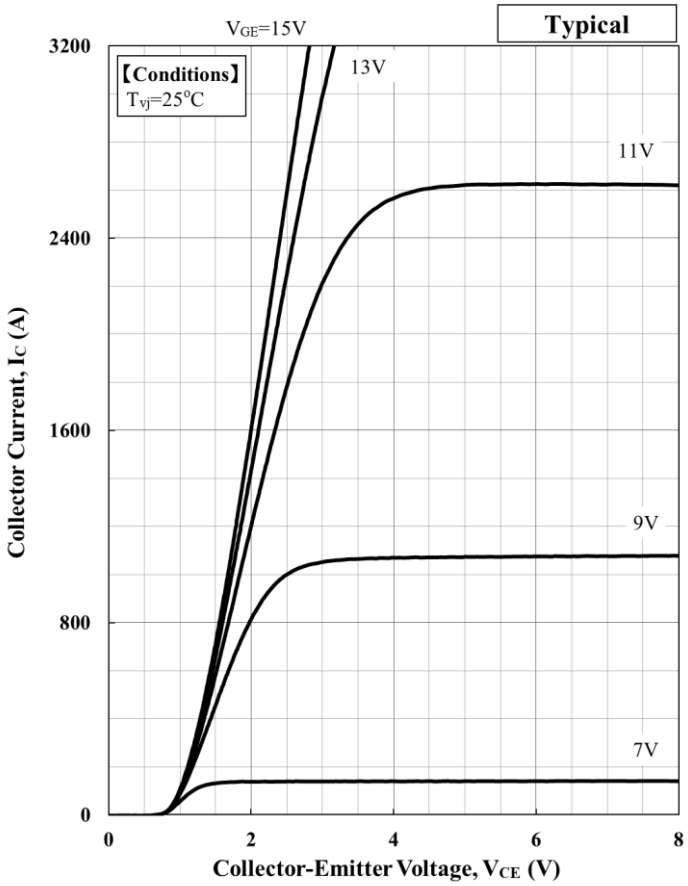
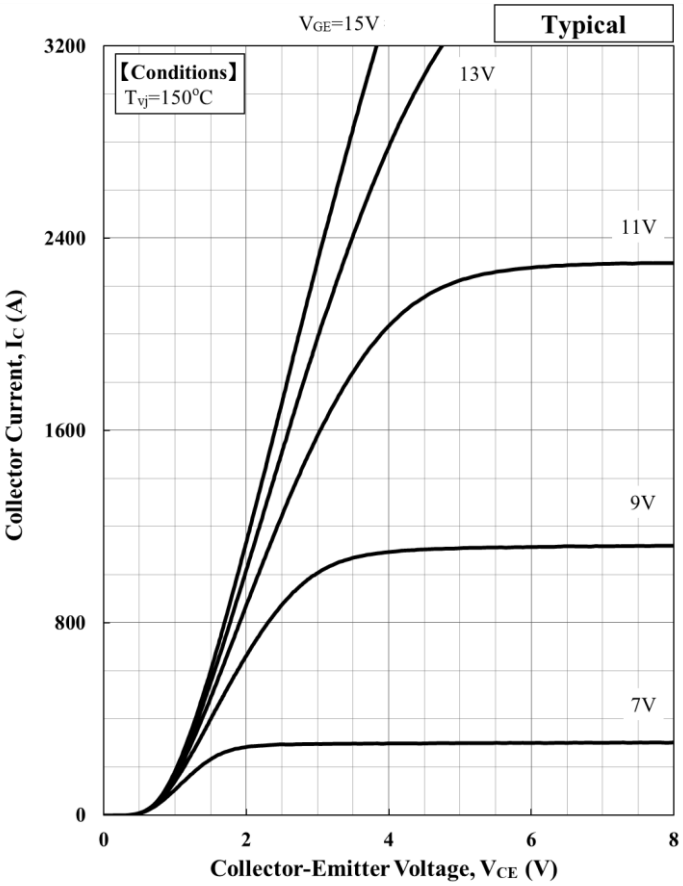
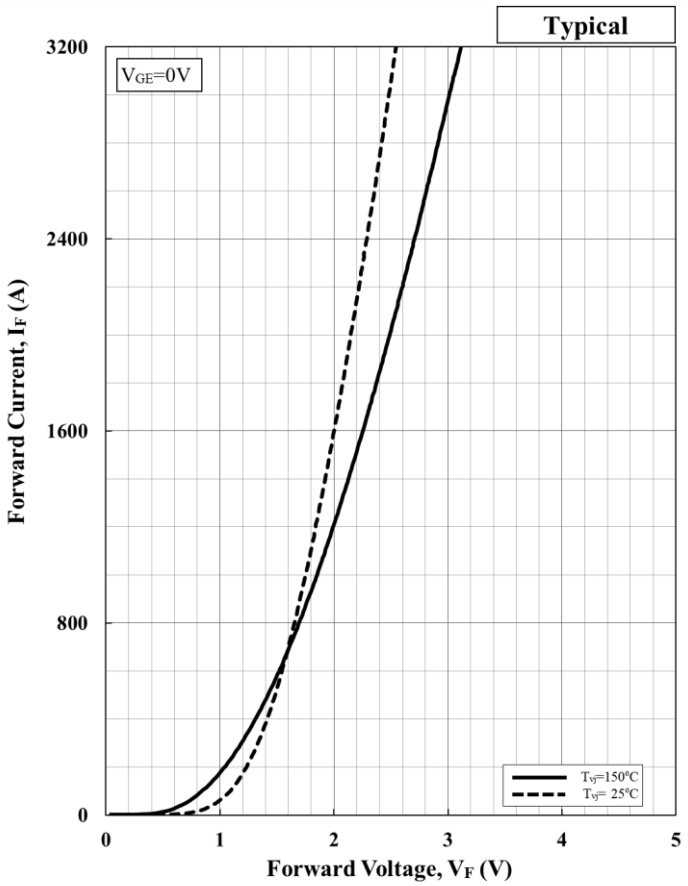


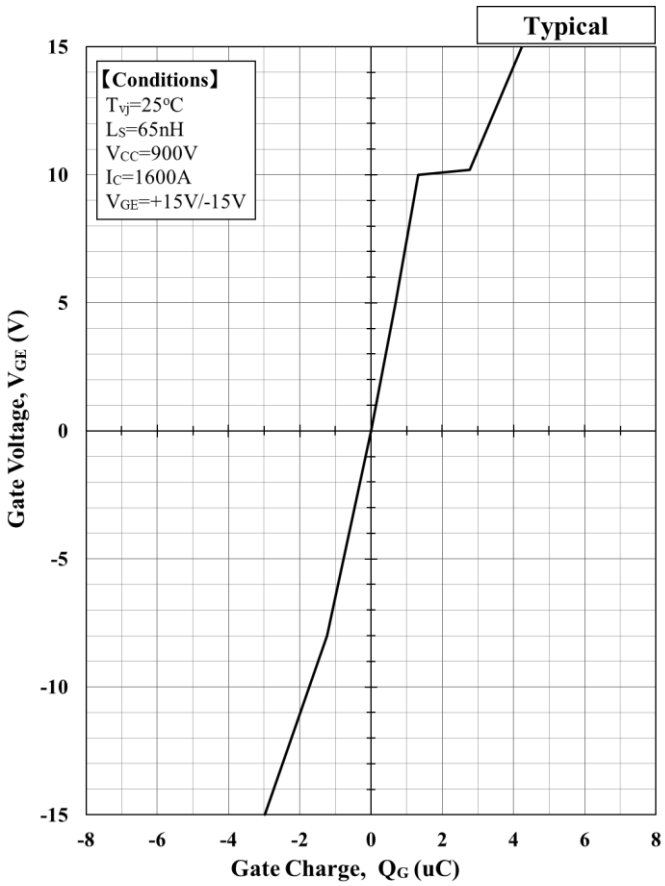
Collector Current vs. Collector Emitter Voltage



Collector Current vs. Collector Emitter Voltage



Forward Voltage of free-wheeling diode



V_{GE}-Q_G curve

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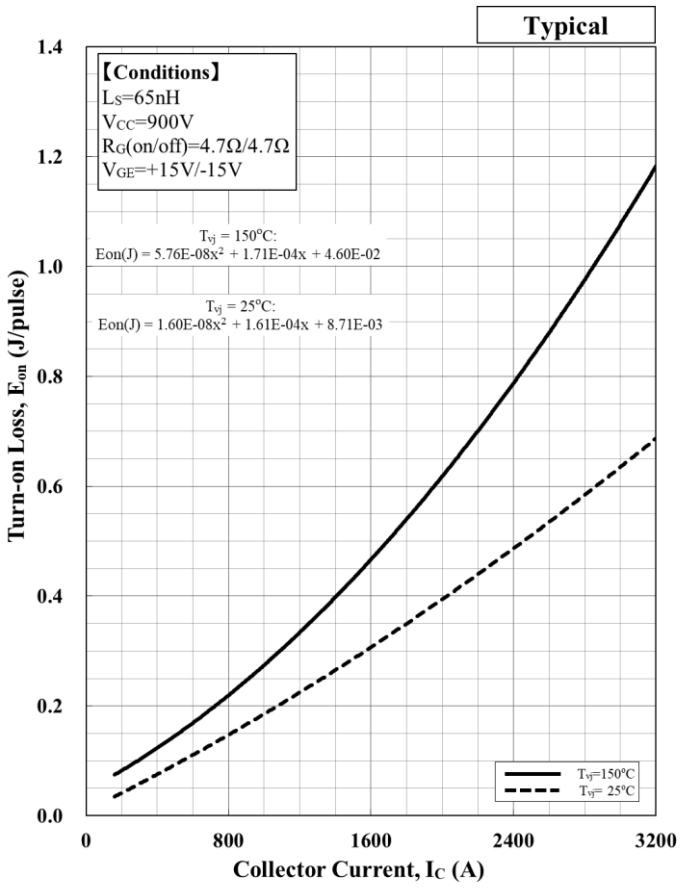
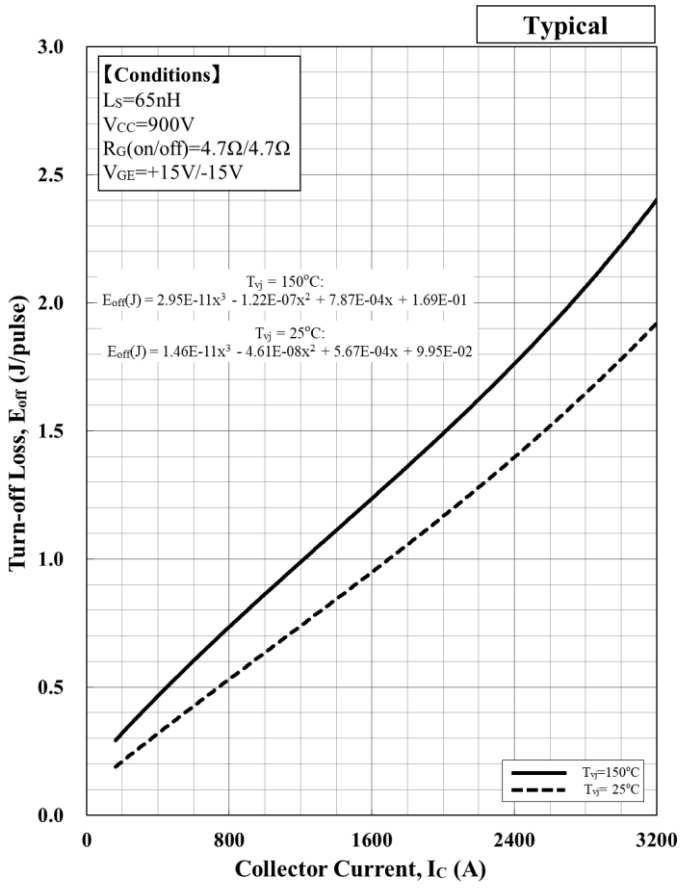
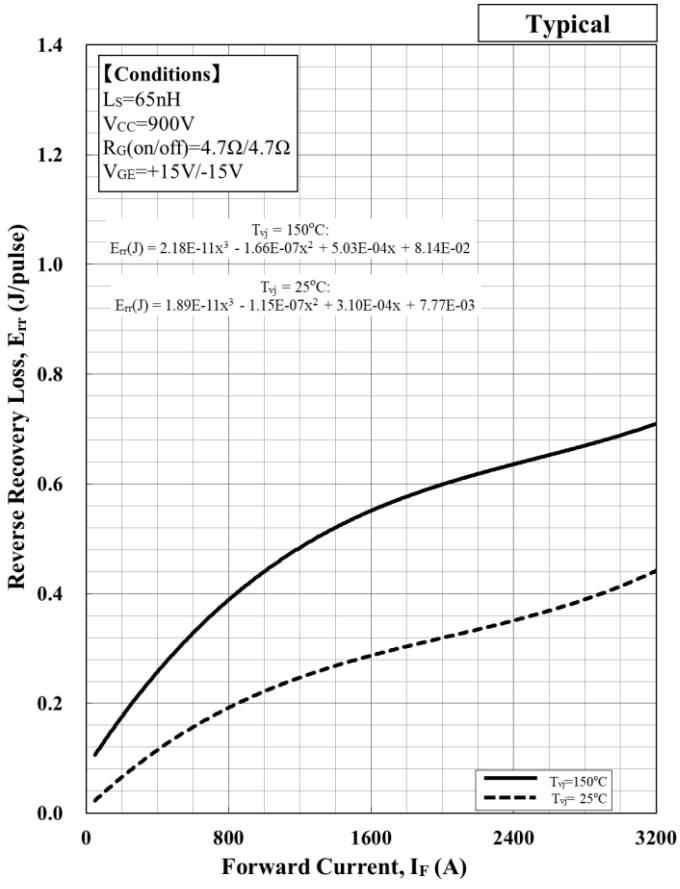


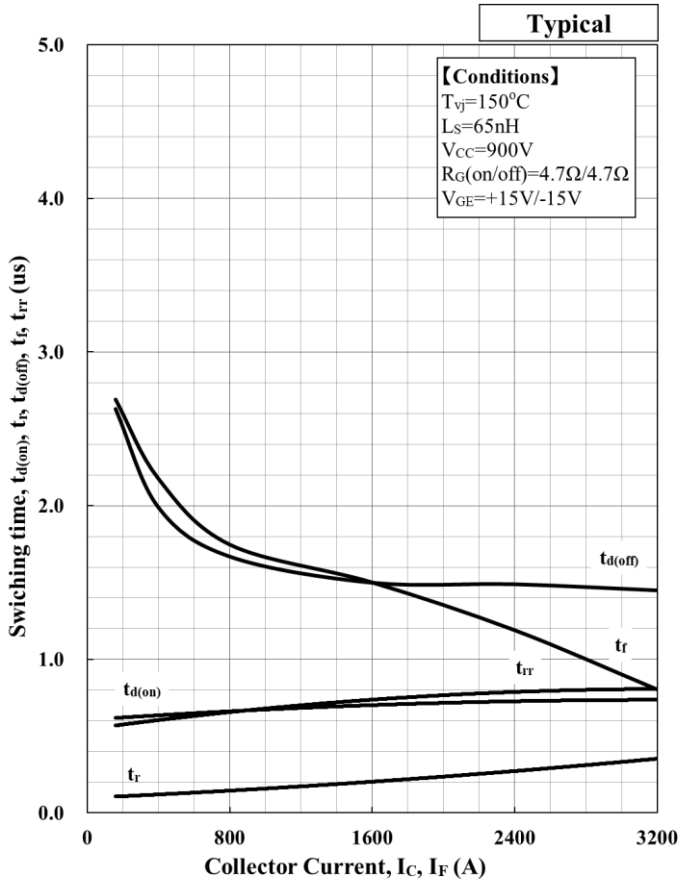
Turn-on loss vs. Collector current



Turn-off loss vs. Collector current



Recovery loss vs. Forward current



Switching time vs. Collector Current

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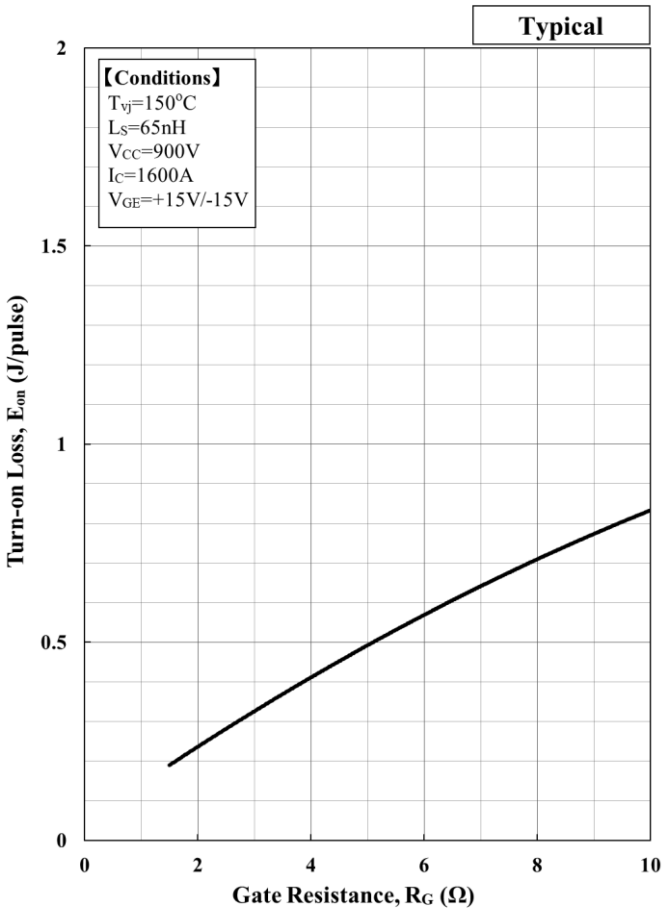
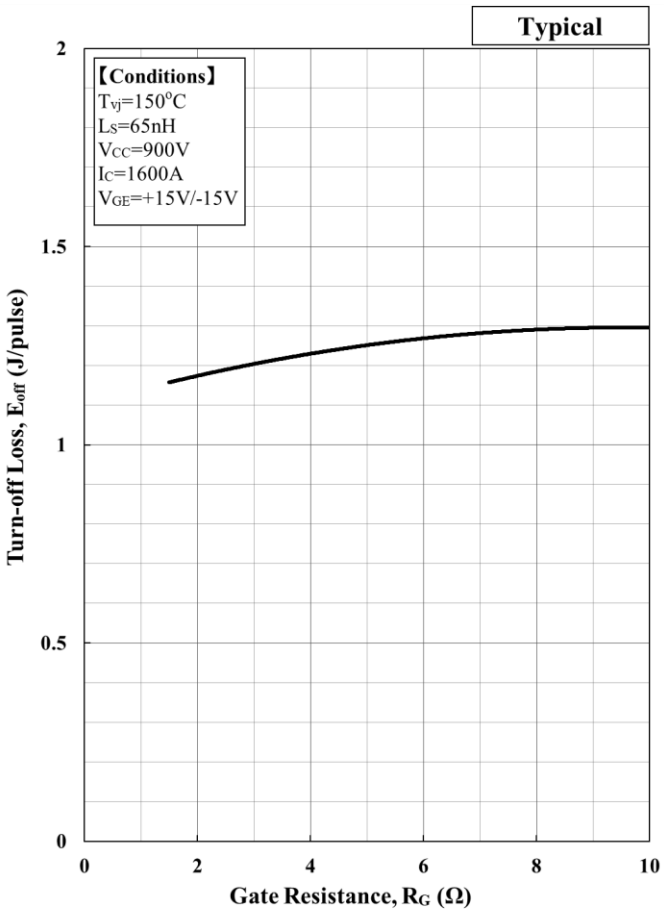
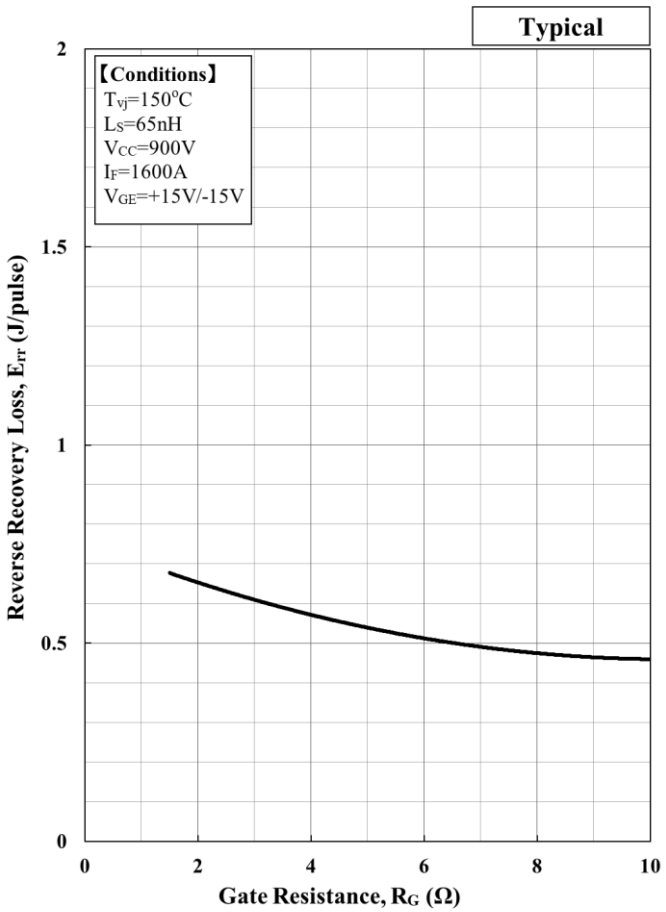


Turn-on loss vs. Gate Resistance



Turn-off loss vs. Gate Resistance



Recovery loss vs. Gate Resistance

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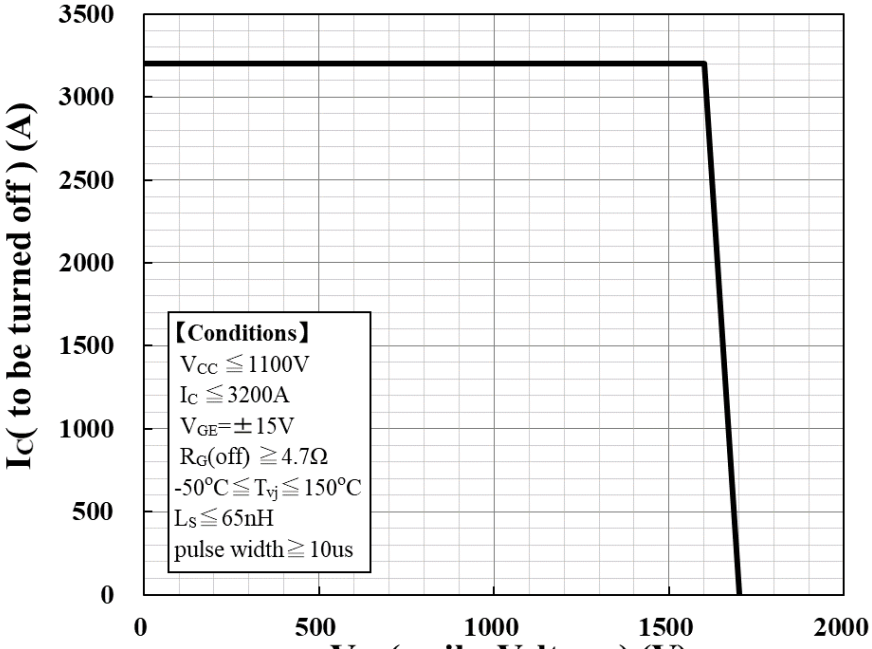
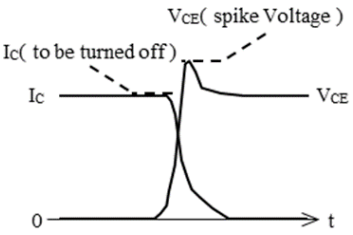
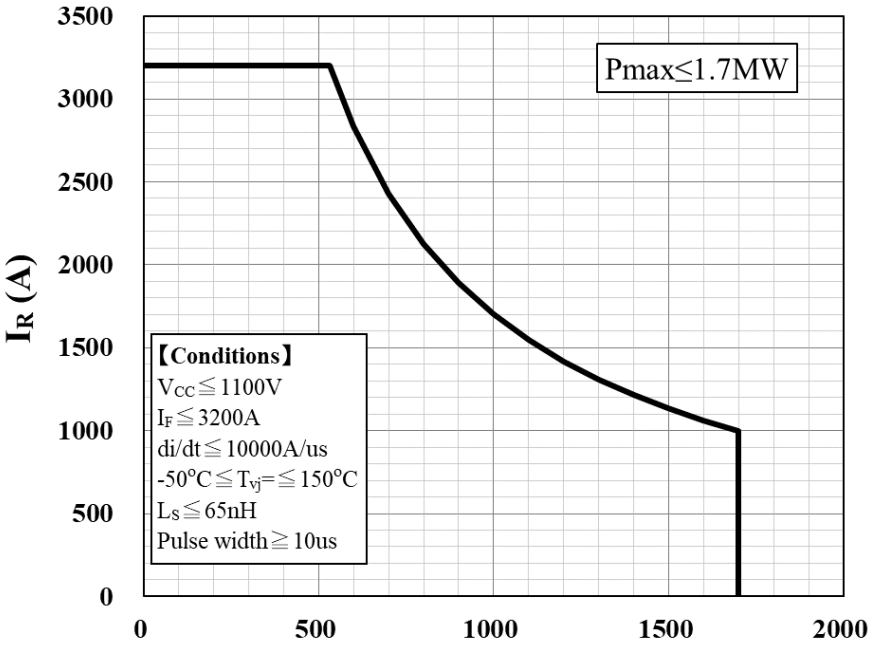


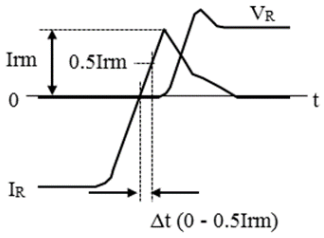
Reverse Bias Safe Operation Area (RBSOA)



Definition of RBSOA waveform



Reverse Recovery Safe Operation Area (RRSOA)



$$di/dt = \frac{0.5Irm}{\Delta t}$$

Definition of Recovery di/dt

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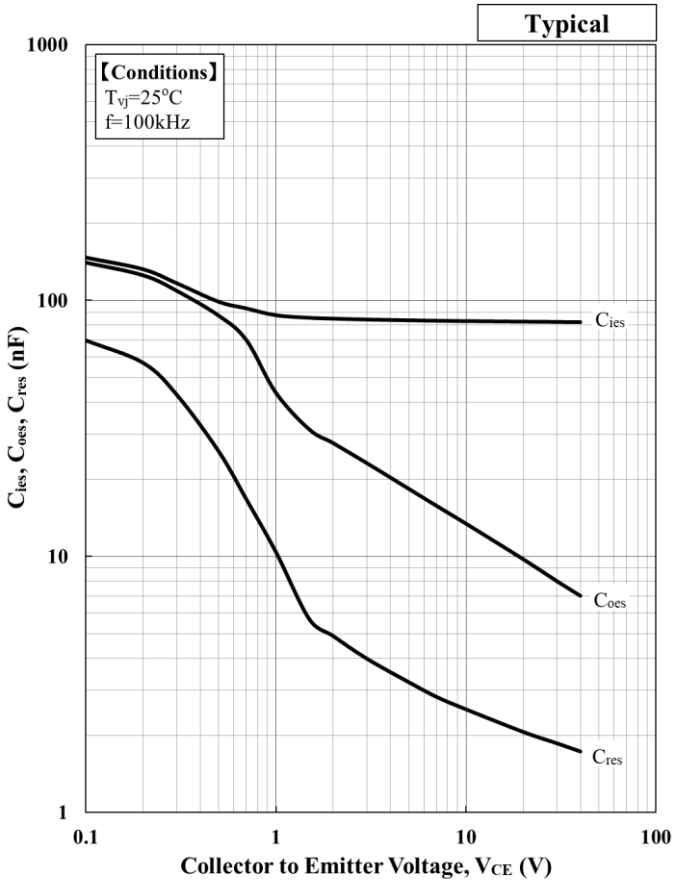
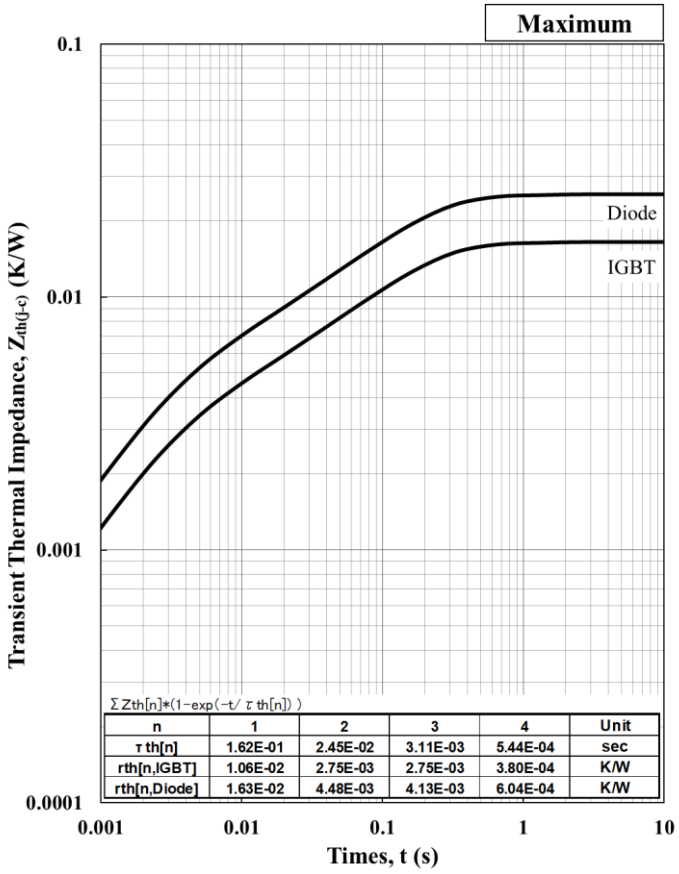


Capacitance vs. Collector to Emitter Voltage



n	1	2	3	4	Unit
τ th[n]	1.62E-01	2.45E-02	3.11E-03	5.44E-04	sec
rth[n,IGBT]	1.06E-02	2.75E-03	2.75E-03	3.80E-04	K/W
rth[n,Diode]	1.63E-02	4.48E-03	4.13E-03	6.04E-04	K/W

Transient Thermal Ipedance Curve

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HITACHI POWER SEMICONDUCTORS

Notices

1. Since mishandling of semiconductor devices may cause malfunctions, please be sure to read "Precautions for Safe Use and Notices" in the individual brochure before use.
2. When designing an electronic circuit using semiconductor devices, please do not exceed the absolute maximum rating specified for the device under any external fluctuations. And for pulse applications, please also do not exceed the "Safe Operating Area (SOA)".
3. Semiconductor devices may sometimes break down by accidental or unexpected surge voltage, so please be careful about the safety design such as redundant design and malfunction prevention design which don't cause the damage expand even if they break down.
4. In cases where extremely high reliability is required (such as use in nuclear power control, aerospace and aviation, traffic equipment, life-support-related medical equipment, fuel control equipment and various kinds of safety equipment), safety should be ensured by using semiconductor devices that feature assured safety or by means of users' fail-safe precautions or other arrangement. Or consult with Hitachi's sales department staff. (When semiconductor devices fail, as a result the semiconductor devices or wiring, wiring pattern may smoke, ignite, or the semiconductor devices themselves may burst.)
5. A semi-processed article is done now using solder which contains lead inside the semiconductor devices. There is possibility of the regulation substance depend on the applied models, so please check before using.
6. This specification is a material for component selection, which describes specifications of power semiconductor devices (hereinafter referred to as products), characteristic charts, and external dimension drawings.
7. The information given herein, including the specifications and dimensions, is subject to change without prior notice to improve product characteristics. Before ordering, purchasers are advised to contact with Hitachi power semiconductor sales department for the latest version of this data sheets.
8. For handling other than described in this manual, follow the handling instructions (IGBT-HI-00002).

■ For inquiries relating to the products, please contact nearest representatives that is located "Inquiry" portion on the top page of a home page.

Hitachi power semiconductor home page address
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HITACHI POWER SEMICONDUCTORS

Usage

1. HPSD warrants that the HPSD products have the specified performance according to the respective specifications at the time of its sale. Testing and other quality control techniques of the HPSD products by HPSD are utilized to the extent HPSD needs to meet the specifications described in this document. Not every device of the HPSD products is specifically tested on all parameters, except those mandated by relevant laws and/or regulations.
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